BF1118; BF1118R; BF1118W; BF1118WR

Silicon RF switches

Rev. 2 — 11 January 2012

Product data sheet

1. Product profile

1.1 General description

These switches are a combination of a depletion type Field-Effect Transistor (FET) and a band-switching diode. The BF1118, BF1118R, BF1118W and BF1118WR are encapsulated in the SOT143B, SOT143R, SOT343N and SOT343R respectively. The low loss and high isolation capabilities of these devices provide excellent RF switching functions. The gate of the MOSFET can be isolated from ground with the diode, resulting in low losses. Integrated diodes between gate and source and between gate and drain protect against excessive input voltage surges.

CAUTION



This device is sensitive to ElectroStatic Discharge (ESD). Therefore care should be taken during transport and handling.

1.2 Features and benefits

Specially designed for low loss RF switching up to 1 GHz

1.3 Applications

- Various RF switching applications such as:
 - Passive loop through for VCR tuner
 - Transceiver switching

1.4 Quick reference data

Table 1. Quick reference data

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
$L_{ins(on)} \\$	on-state insertion loss	$\begin{split} R_S &= R_L = 50 \; \Omega; f \leq 1 \; GHz; \\ V_{SK} &= V_{DK} = 0 \; V; I_F = 0 \; mA \end{split}$	[1] -	-	2.5	dB
ISL _{off}	off-state isolation	$\begin{split} R_S &= R_L = 50 \ \Omega; \ f \leq 1 \ GHz; \\ V_{SK} &= V_{DK} = 3.3 \ V; \ I_F = 1 \ mA \end{split}$	30	-	-	dB
R _{DSon}	drain-source on-state resistance	$V_{KS} = 0 V; I_D = 1 mA$	-	15	23.3	Ω
$V_{GS(p)}$	gate-source pinch-off voltage	$V_{DS} = 1 \text{ V; } I_D = 20 \mu\text{A}$	-	-2	-2.44	V

^[1] $I_F = diode forward current.$



2. Pinning information

Table 2. Pinning

Pin	Description	Sim	plified outline	Graphic symbol
BF11	18 (SOT143B)			
1	FET gate; diode anode			
2	diode cathode		4 3	4 3
3	source	[1]		
4	drain	[1]	1 2	1 2 001aai042
BF11	18R (SOT143R)			
1	FET gate; diode anode			
2	diode cathode		3 4	3 4
3	source	[1]		
4	drain	[1]	2 1	2 1 001aai043
BF11	18W (SOT343N)			
1	FET gate; diode anode		4 0	4 0
2	diode cathode		4 3	4 3
3	source	<u>[1]</u>		
4	drain	<u>[1]</u>	1 2	1 2 001aai042
BF11	18WR (SOT343R)			
1	FET gate; diode anode			
2	diode cathode		3 4	3 4
3	source	<u>[1]</u>		
4	drain	[1]	2 1	2 1 001aai043

^[1] Drain and source are interchangeable.

3. Ordering information

Table 3. Ordering information

Type number	Package				
	Name	Description	Version		
BF1118	-	plastic surface-mounted package; 4 leads	SOT143B		
BF1118R	-	plastic surface-mounted package; reverse pinning; 4 leads	SOT143R		
BF1118W	-	plastic surface-mounted package; 4 leads	SOT343N		
BF1118WR	-	plastic surface-mounted package; reverse pinning; 4 leads	SOT343R		

BF1118_1118R_1118W_1118WR

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4. Marking

Table 4. Marking

Type number	Marking code
BF1118	VC%
BF1118R	VD%
BF1118W	VB
BF1118WR	VC

5. Limiting values

Table 5. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Min	Max	Unit
FET					
V_{DS}	drain-source voltage		-	3	V
V_{SD}	source-drain voltage		-	3	V
V_{DG}	drain-gate voltage		-	7	V
V_{SG}	source-gate voltage		-	7	V
I _D	drain current		-	10	mΑ
Diode					
V_R	reverse voltage		-	35	V
l _F	forward current		-	100	mΑ
FET and d	iode				
T _{stg}	storage temperature		-65	+150	°C
Tj	junction temperature		-	150	°C

6. Thermal characteristics

Table 6. Thermal characteristics

Symbol	Parameter	Conditions	Тур	Unit
$R_{th(j-sp)}$	thermal resistance from junction to solder point		[1] 250	K/W

^[1] Soldering point of FET gate and diode anode lead.

7. Static characteristics

Table 7. Static characteristics

 $T_i = 25$ °C unless otherwise specified.

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
FET						
$V_{(BR)GSS}$	gate-source breakdown voltage	$V_{DS} = 0 \text{ V}; I_{GS} = 0.1 \text{ mA}$	7	-	-	V
$V_{GS(p)}$	gate-source pinch-off voltage	$V_{DS} = 1 \text{ V}; I_D = 20 \mu A$	-	-2	-2.44	V
I _{DSX}	drain cut-off current	$V_{GS} = -3.3 \text{ V}; V_{DS} = -1 \text{ V}$	-	-	16	μΑ
I _{GSS}	gate leakage current	$V_{GS} = -3.3 \text{ V}; V_{DS} = 0 \text{ V}$	-	-	100	nA
R _{DSon}	drain-source on-state resistance	$V_{GS} = 0 \text{ V}; I_D = 1 \text{ mA}$	-	15	23.3	Ω
Diode						
V_{F}	forward voltage	I _F = 10 mA	-	-	1	V
I _R	reverse current	V _R = 25 V	-	-	50	nA
		$V_R = 20 \text{ V}; T_{amb} = 75 ^{\circ}\text{C}$	-	-	1	μΑ

8. Dynamic characteristics

Table 8. Dynamic characteristics Common cathode; $T_{amb} = 25$ °C.

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
FET and	diode					
L _{ins(on)}	on-state insertion loss	$V_{SK} = V_{DK} = 0 \text{ V}; I_F = 0 \text{ mA}$	<u>[1]</u>			
		$R_S = R_L = 50 \Omega$; $f \le 1 GHz$	-	-	2.5	dB
		$R_S = R_L = 50 \Omega$; $f = 1 GHz$	-	1.5	-	dB
		$R_S = R_L = 75 \Omega$; $f \le 1 GHz$	-	-	2.5	dB
ISL _{off}	off-state isolation	$V_{SK} = V_{DK} = 3.3 \text{ V}; I_F = 1 \text{ mA}$				
		$R_S = R_L = 50 \Omega$; $f \le 1 GHz$	30	-	-	dB
		$R_S = R_L = 50 \Omega$; $f = 1 GHz$	-	35	-	dB
		$R_S = R_L = 75 \Omega$; $f \le 1 GHz$	30	-	-	dB
R _{DSon}	drain-source on-state resistance	$V_{KS} = 0 \text{ V}; I_D = 1 \text{ mA}$	-	15	23.3	Ω
Ci	input capacitance	f = 1 MHz	<u>[2]</u>			
		$V_{SK} = V_{DK} = 3.3 \text{ V}; I_F = 1 \text{ mA}$	-	1	-	pF
		$V_{SK} = V_{DK} = 0 V$; $I_F = 0 mA$	-	0.65	0.9	pF
Co	output capacitance	f = 1 MHz	<u>[2]</u>			
		$V_{SK} = V_{DK} = 3.3 \text{ V}; I_F = 1 \text{ mA}$	-	1	-	pF
		$V_{SK} = V_{DK} = 0 V$; $I_F = 0 mA$	-	0.65	0.9	pF
Diode						
C_d	diode capacitance	$f = 1 \text{ MHz}; V_R = 0 \text{ V}$	-	1.1	-	pF
r _D	diode forward resistance	$I_F = 2 \text{ mA}; f = 100 \text{ MHz}$	<u>[3]</u> _	-	0.9	Ω

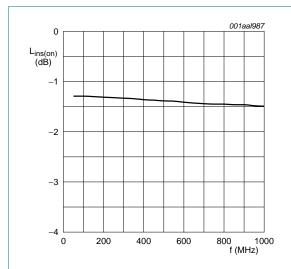
^[1] $I_F = \text{diode forward current}$.

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^[2] C_i is the series connection of C_{GS} and C_{GK} ; C_o is the series connection of C_{GD} and C_{GK} .

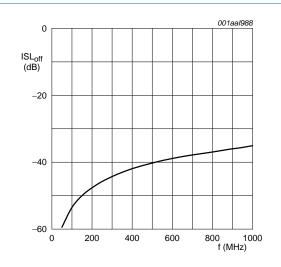
^[3] Guaranteed on AQL basis; inspection level S4, AQL 1.0.



 $V_{SK} = V_{DK} = 0$ V; $R_S = R_L = 50~\Omega;$ $I_F = 0~mA$ (diode forward current).

Measured in test circuit; see Figure 3.

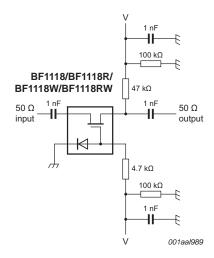
Fig 1. On-state insertion loss as a function of frequency; typical values



 V_{SK} = V_{DK} = 3.3 V; R_S = R_L = 50 $\Omega;$ I_F = 1 mA (diode forward current).

Measured in test circuit; see Figure 3.

Fig 2. Off-state isolation as a function of frequency; typical values



On-state: V = 0 V. Off-state: V = 3.3 V.

Fig 3. Test circuit

BF1118_1118R_1118W_1118WR

9. Package outline

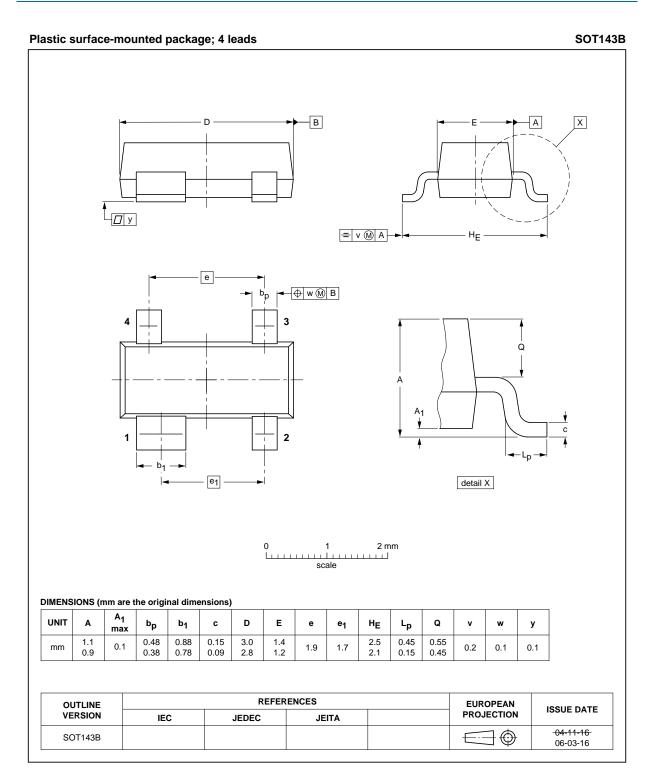


Fig 4. Package outline SOT143B

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Plastic surface-mounted package; reverse pinning; 4 leads SOT143R В - A Х = v M A ΗE е - w M B e₁ detail X scale **DIMENSIONS** (mm are the original dimensions) Α₁ bp UNIT С D Ε Q Α e₁ H_{E} $L_{\mathbf{p}}$ ν у max 0.48 0.88 0.15 3.0 0.55 1.4 2.5 0.45 1.1 0.1 1.9 1.7 0.2 0.1 0.1 $\mathsf{m}\mathsf{m}$ 0.9 0.38 0.78 0.09 1.2 0.25 0.25 2.8 REFERENCES **EUROPEAN** OUTLINE ISSUE DATE **PROJECTION VERSION** IEC **JEDEC JEITA** -04-11-16 SOT143R SC-61AA \bigcirc 06-03-16

Fig 5. Package outline SOT143R

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Plastic surface-mounted package; 4 leads

SOT343N

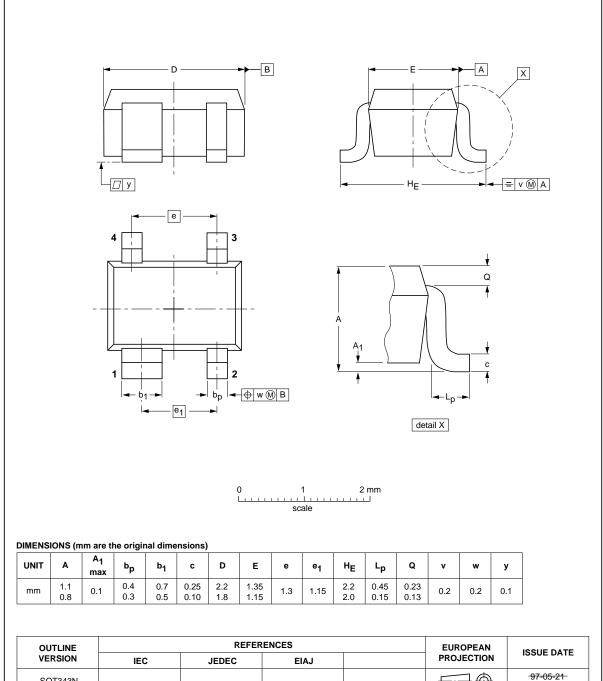


Fig 6. Package outline SOT343N

SOT343N

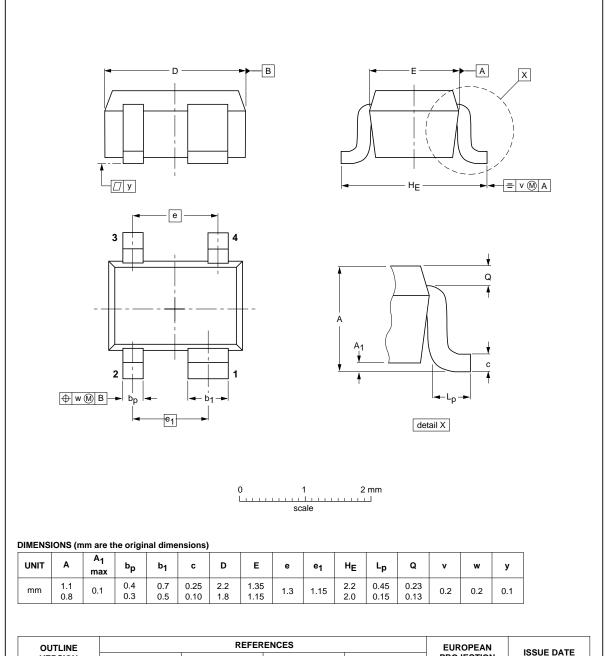
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06-03-16

 \bigcirc

Plastic surface-mounted package; reverse pinning; 4 leads

SOT343R



OUTLINE		REFER	RENCES	EUROPEAN	ISSUE DATE	
VERSION	IEC	JEDEC	EIAJ	PROJECTION	ISSUE DATE	
SOT343R					97-05-21 06-03-16	

Fig 7. Package outline SOT343R

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10. Abbreviations

Table 9.	∆hhreviations

Acronym	Description
AQL	Acceptable Quality Level
MOSFET	Metal-Oxide Semiconductor Field-Effect Transistor
RF	Radio Frequency
S4	Special inspection level 4
VCR	Video Cassette Recorder

11. Revision history

Table 10. Revision history

Document ID	Release date	Data sheet status	Change notice	Supersedes
BF1118_1118R_1118W_1118WR v.2	20120111	Product data sheet	-	BF1118_1118R_1118W_ 1118WR v.1
Modifications:	• <u>Figure 3</u> : o	changed left-side outpo	ut to input	
BF1118_1118R_1118W_1118WR v.1	20100629	Product data sheet	-	-

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Document status[1][2]	Product status[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
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